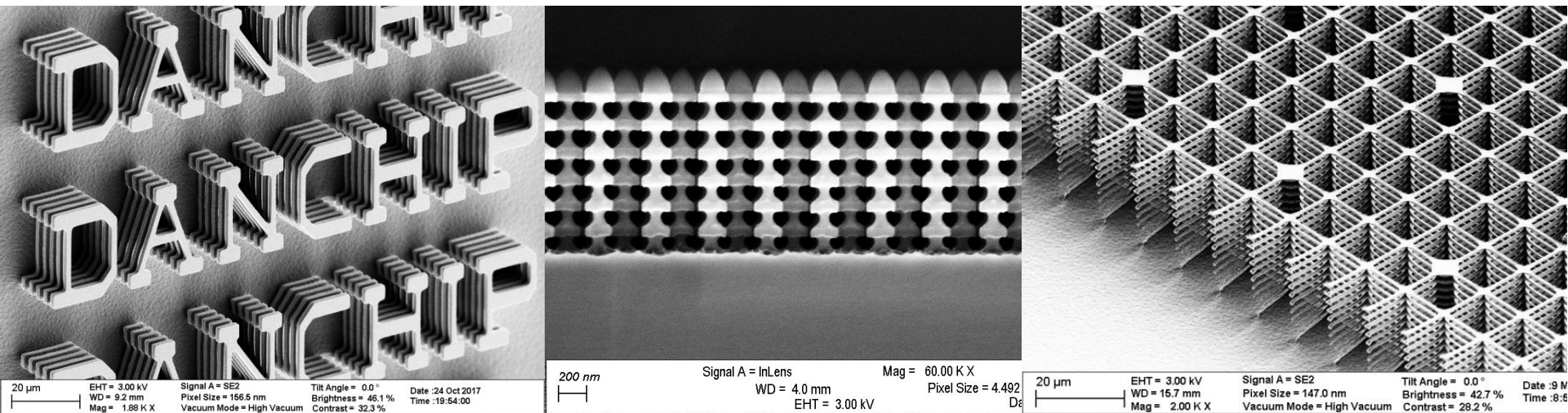


E1: Generic build-up of etch process: 3D-sculpturing by Si plasma etching (ADVANCED)

# Technology Development of 3D Silicon Plasma Etching Processes for Novel Devices and Applications

Bingdong Chang  
Postdoc, DTU Nanolab  
7 May 2019



## 1. Introduction of the etching tool

- Etching machine: DRIE-Pegasus (SPTS);
- Real time monitoring system: OEI/OES, Claritas EPD, Oscilloscope, etc.

## 2. Introduction of the etching strategy

- DREM process;
- 3D DREM process.

## 3. Applications of fabricated 3D silicon micro- and nanostructures

- 3D photonic crystal membranes;
- ZnO nanowires/3D silicon micromesh for photocurrent and photocatalysis

## 4. Conclusions and perspectives

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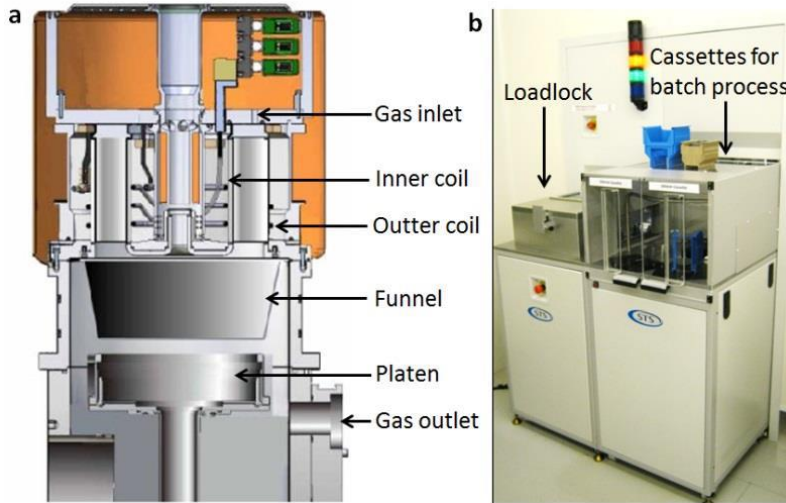
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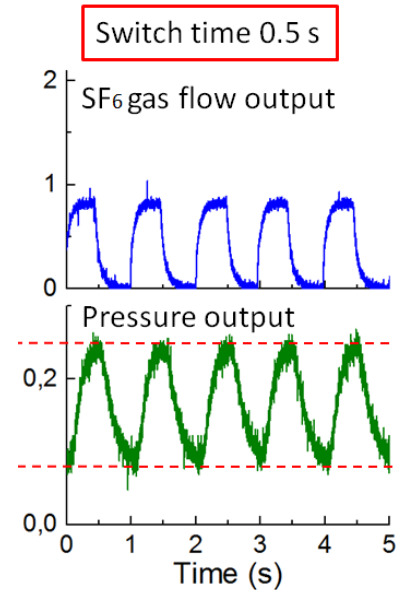
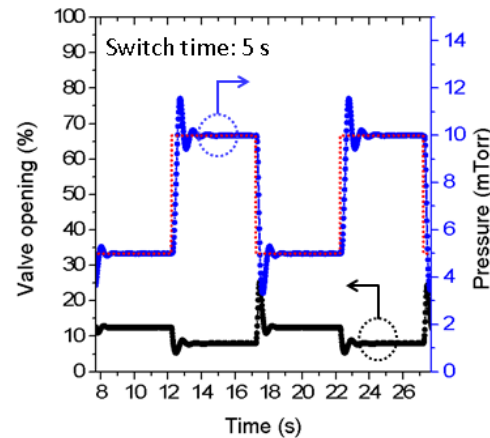
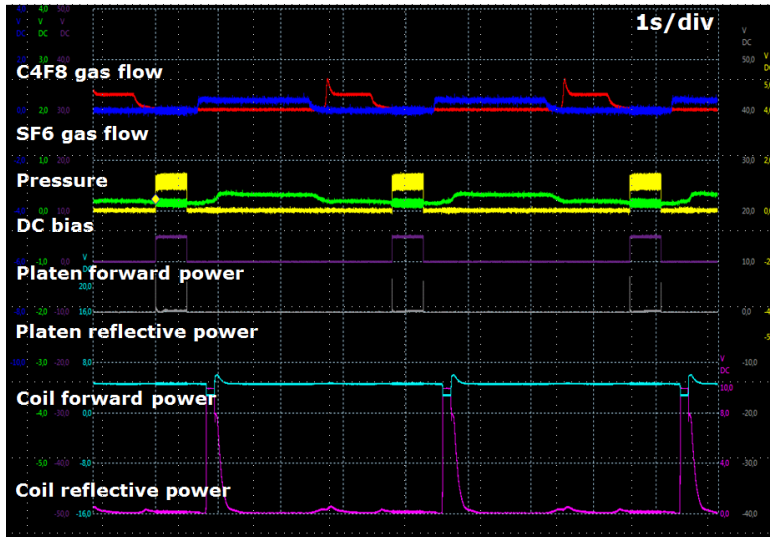
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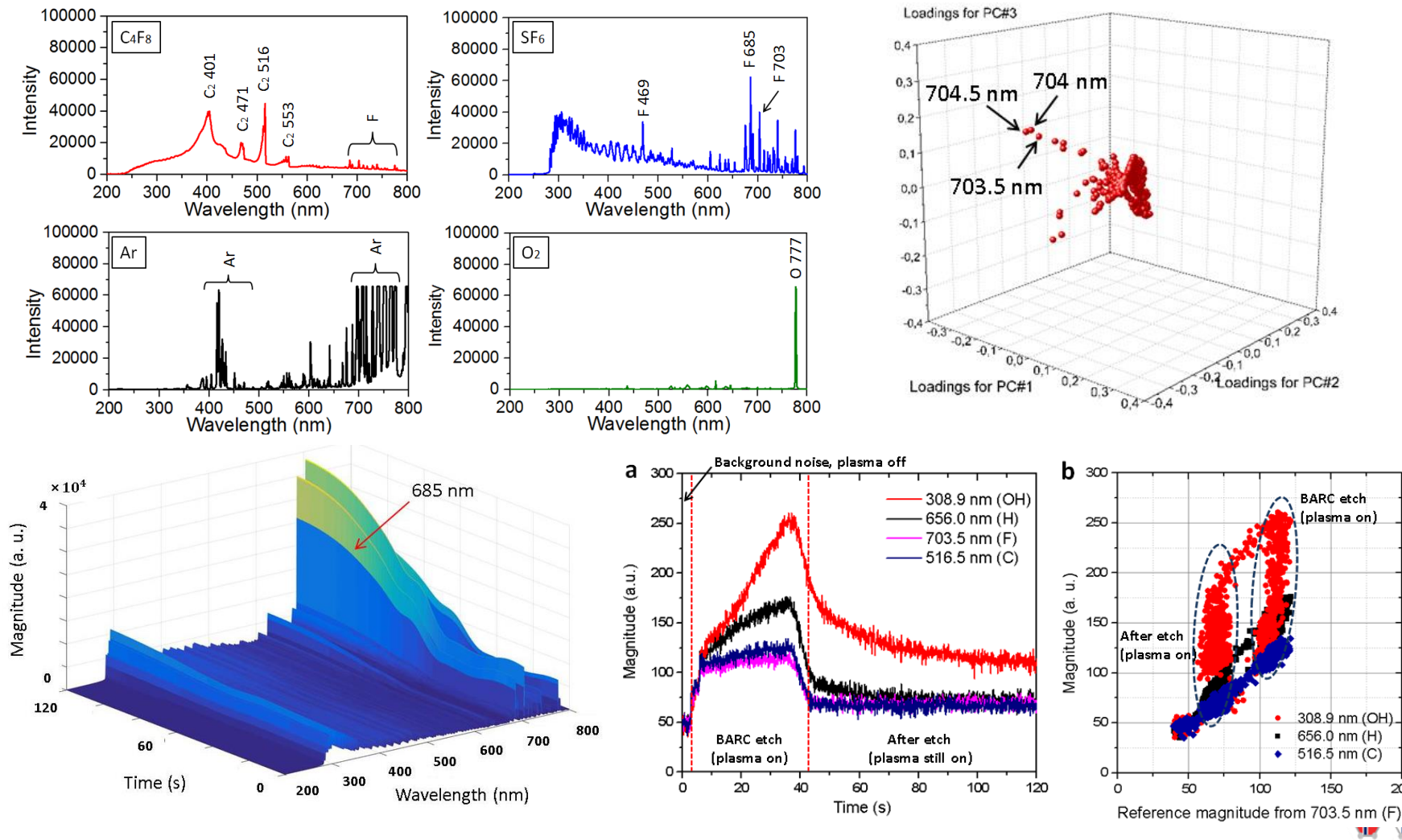


- DRIE-Pegasus (SPTS);
- Installed real time monitoring systems for precise process control;
- Oscilloscope;
- Optical emission spectroscopy (OES);
- Optical emission interferometry (OEI);
- Claritas end-point detection system.



# Optical emission spectroscopy (OES)

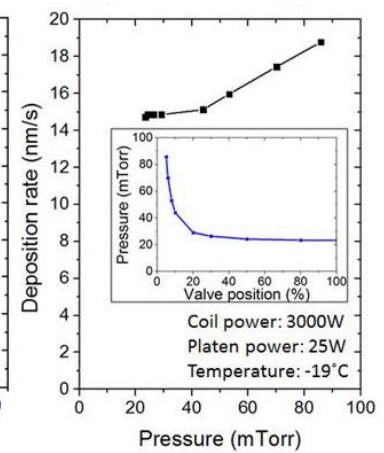
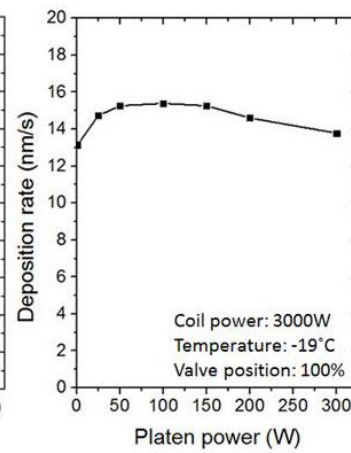
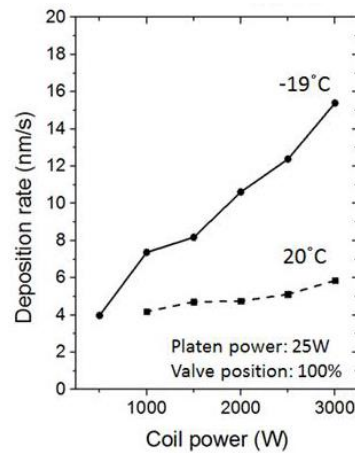
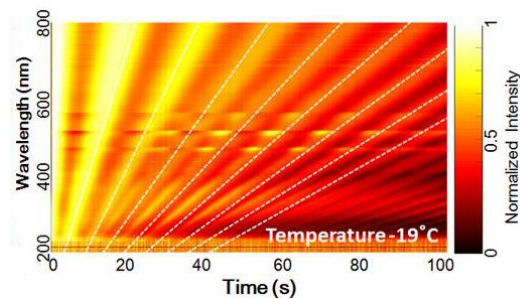
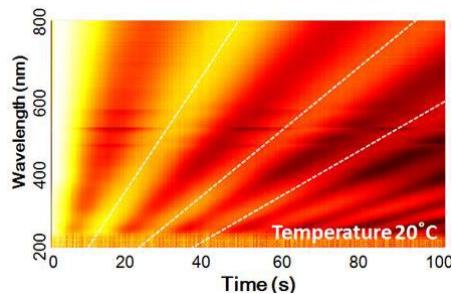
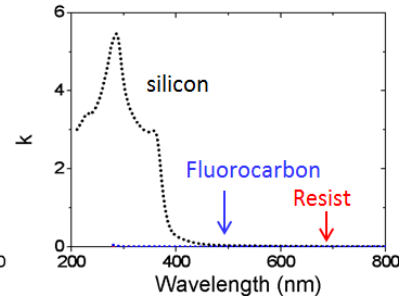
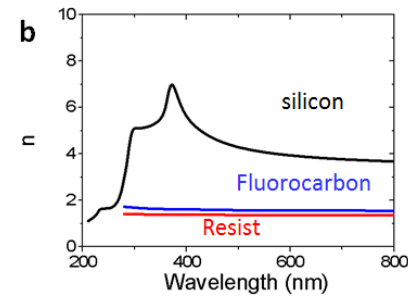
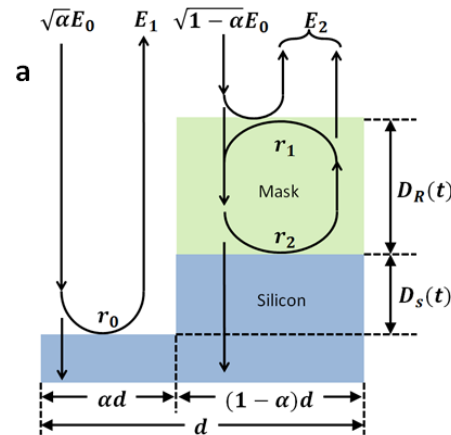
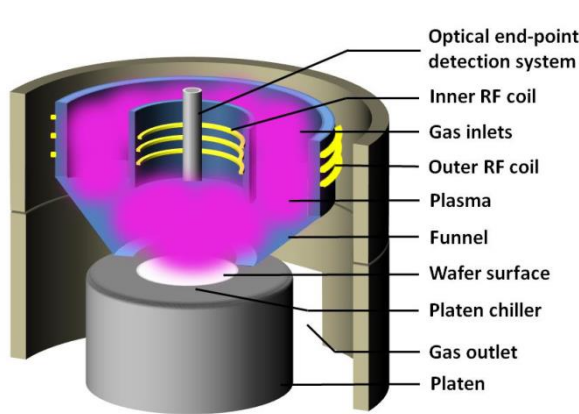
- Tracing the "fingerprints" of different species;
- Principal component analysis (PCA) to choose best wavelength for analysis;
- End-point detection of silicon etch and BARC etch.





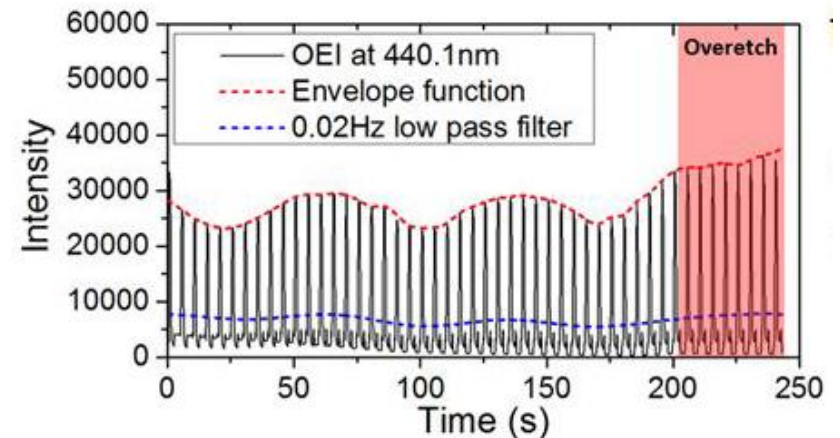
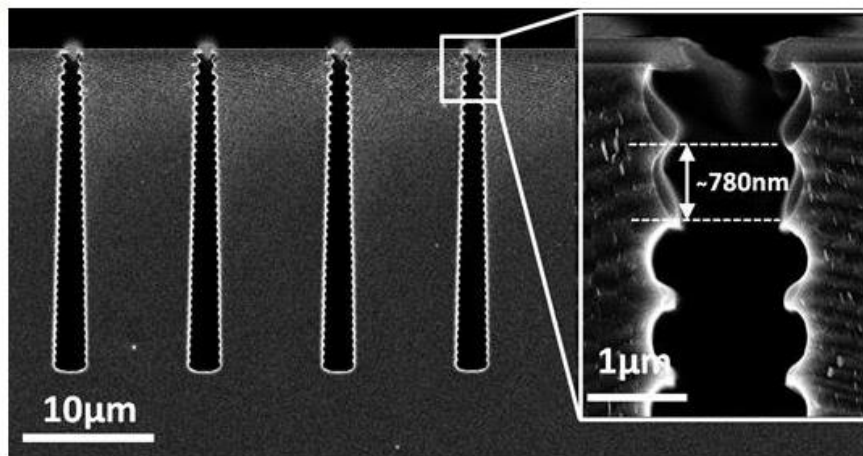
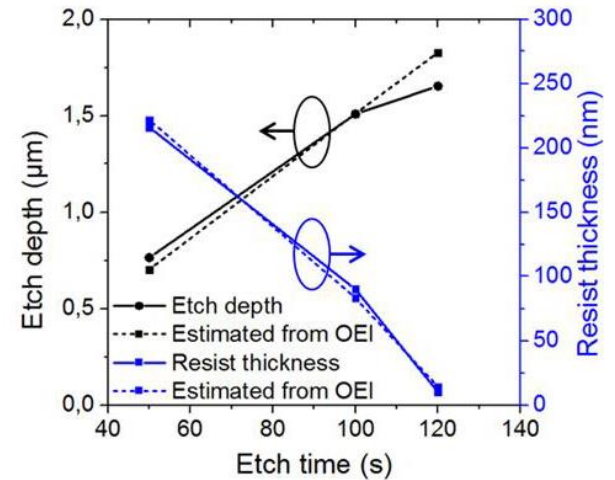
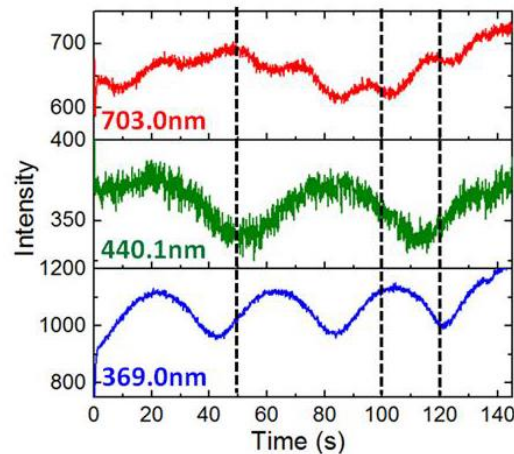
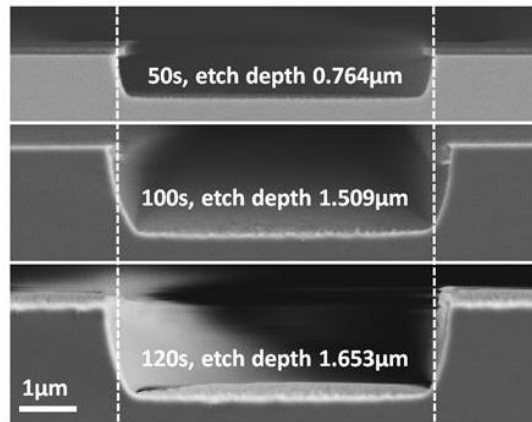
# Optical emission interferometry (OEI)

- Studying etch mechanism (e.g. fluorocarbon deposition process);



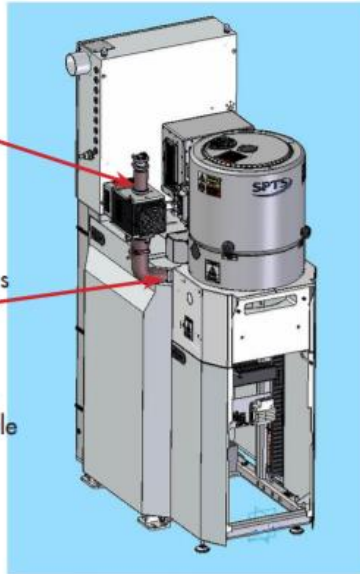
# Optical emission interferometry (OEI)

- Real time monitoring of mask etch rate;
- Real time monitoring of silicon microstructures etch rate.



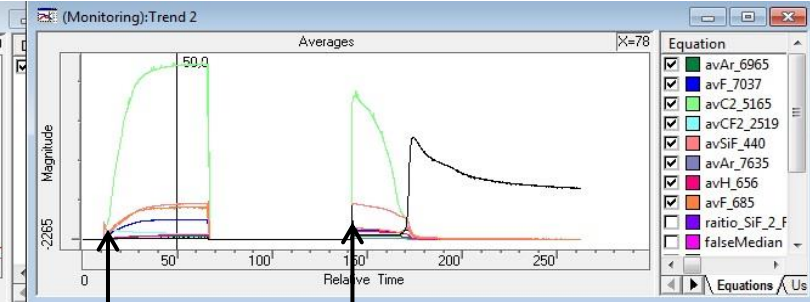
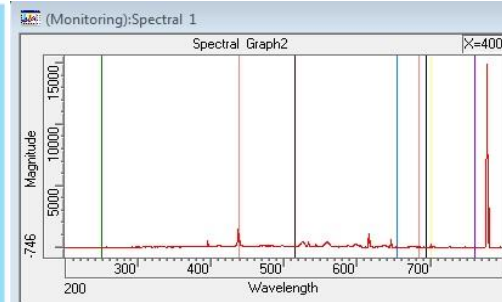
# CLARITAS endpoint detection system

- Endpoint detection based on OES inside a sub-chamber;
- Good signal for low loading area < 2%



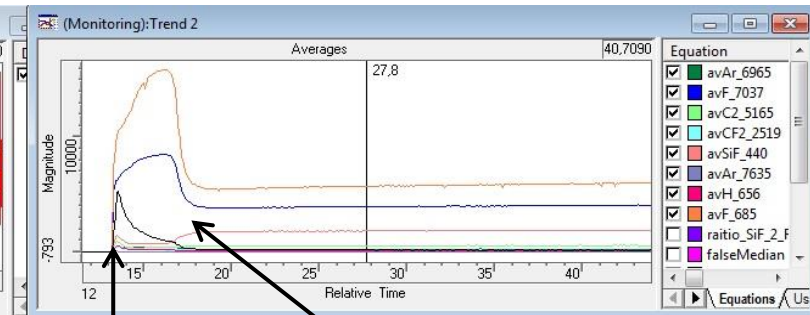
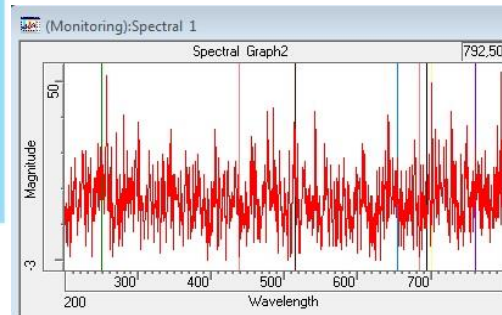
Removal  
Dep  
Etch

SPTS



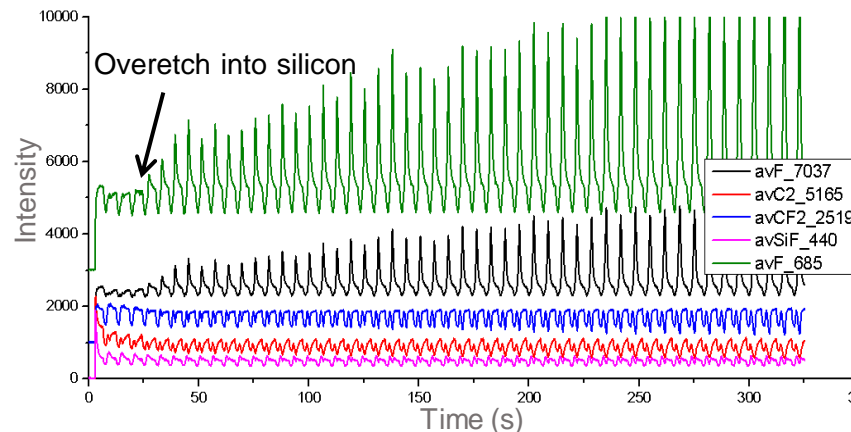
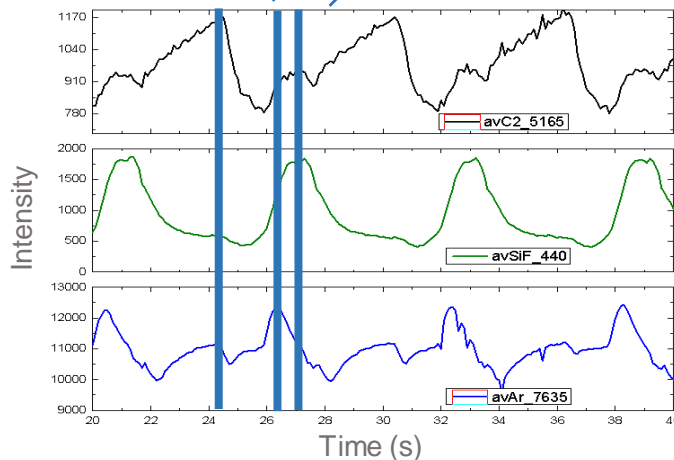
C4F8 deposition

O2 clean



Native oxide etch

Silicon etch





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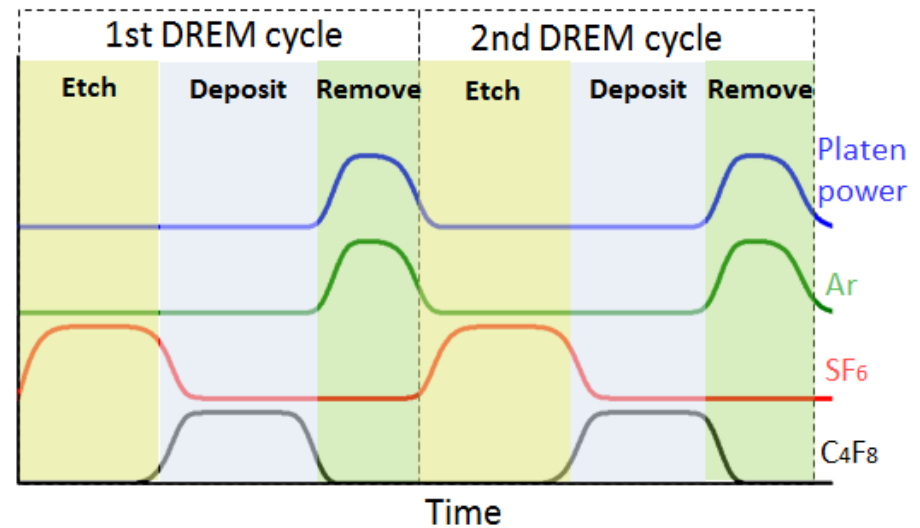
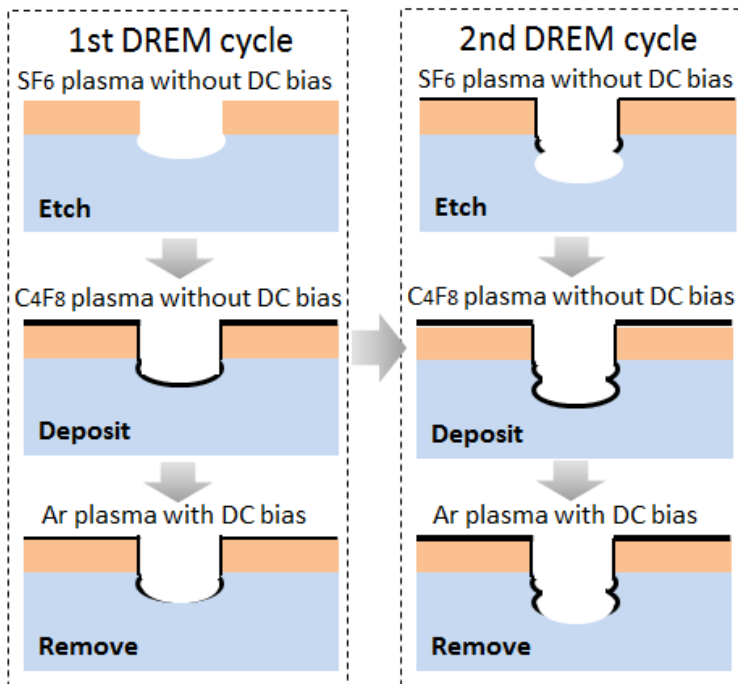
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## 4. Conclusions and perspectives

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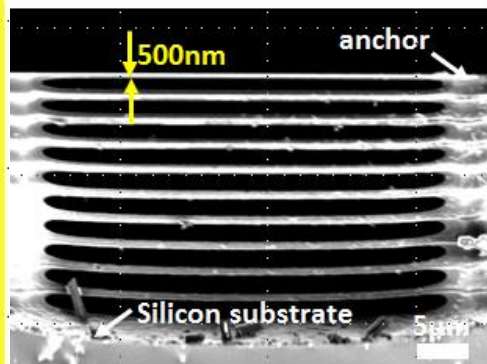
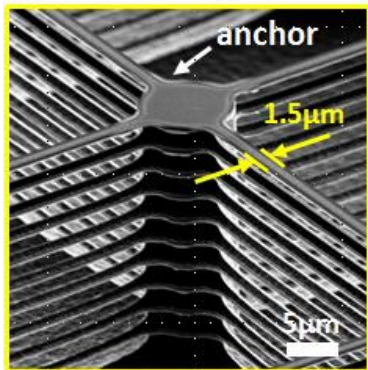
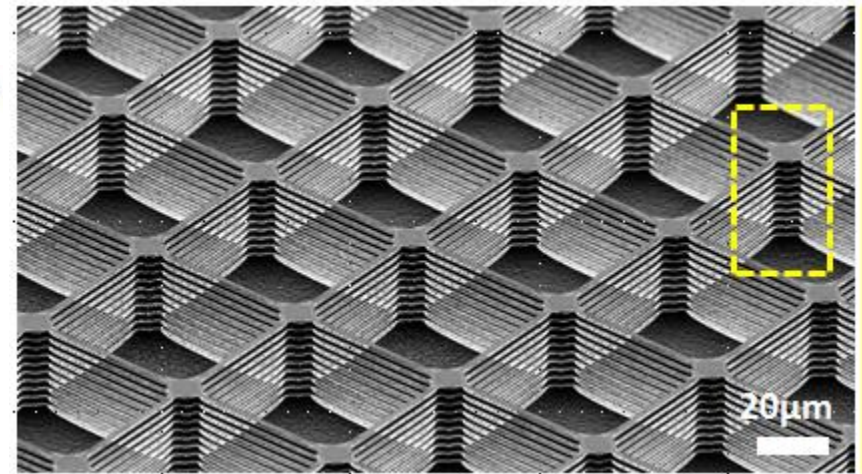
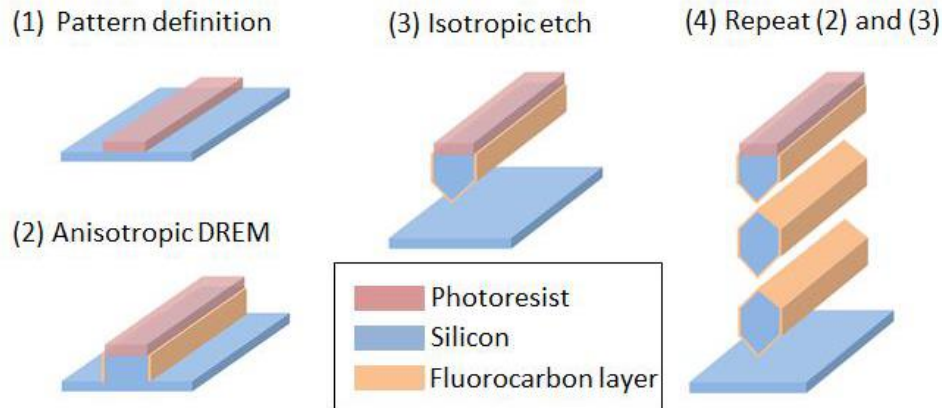
DREM process (a modified Bosch process):

- 3 step process: **D**eposit, **R**emove, **E**tch **M**ethod;  
Deposit: low platen power to reduce sputtering;  
Remove: low pressure argon to create anisotropic profile;  
Etch: low platen power to reduce scallops.
- Parameter ramping for uniform scallop size distributions.



## 3D silicon structures fabrication with DREM process

- Combining DREM process with isotropic etch process;
- Control the sizes of suspended structures.



IOP Publishing  
Journal of Micromechanics and Microengineering  
J. Micromech. Microeng. 28 (2018) 105012 (10pp)  
<https://doi.org/10.1088/1361-6439/aad0c4>

### DREM2: a facile fabrication strategy for freestanding three dimensional silicon micro- and nanostructures by a modified Bosch etch process

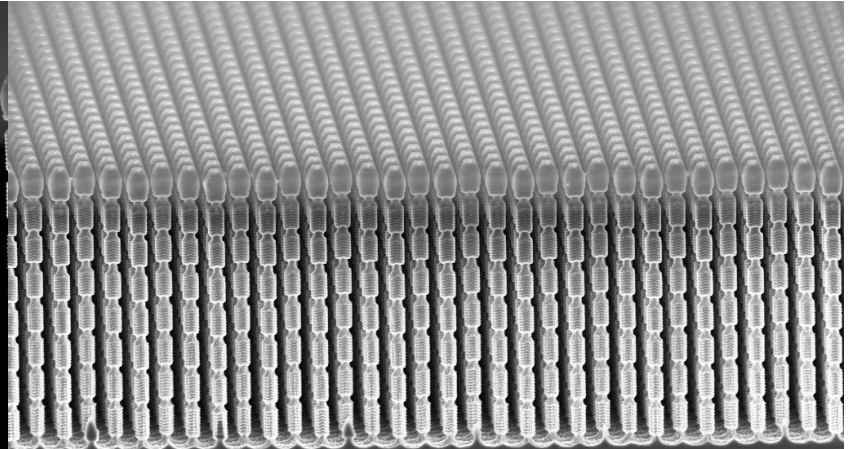
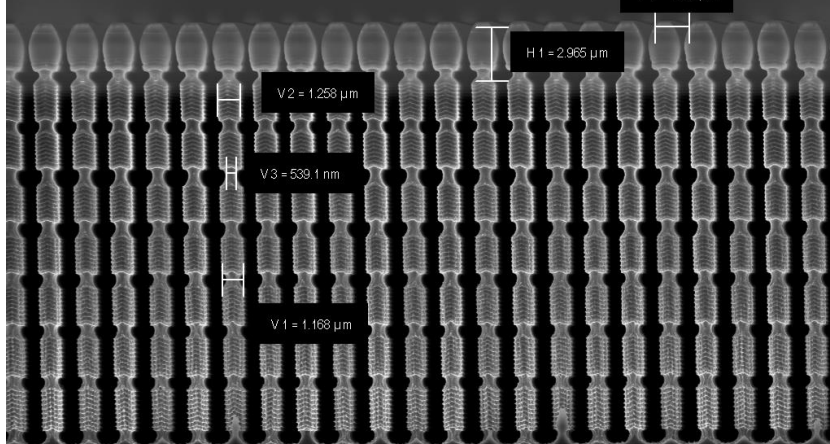
Bingdong Chang, Flemming Jensen, Jörg Hübner and Henri Jansen

DTU Danchip CEN, Technical University of Denmark, Ørsted Plads, Building 347, 2800 Kgs. Lyngby, Denmark

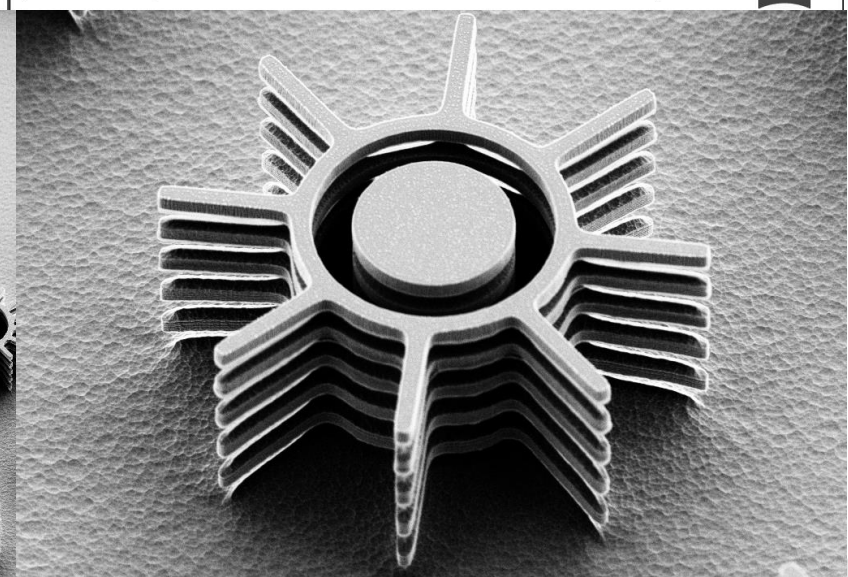
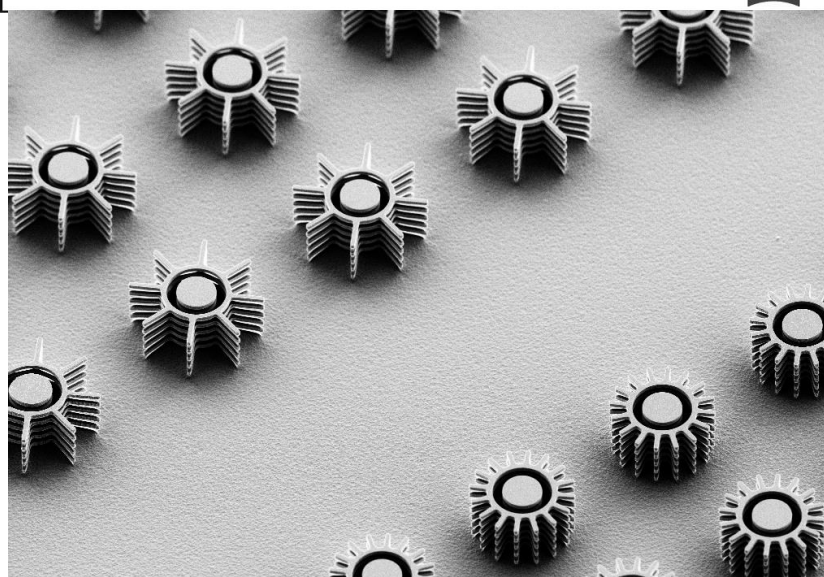
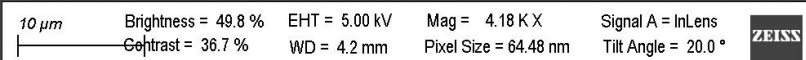


## 3D microstructures created with modified DREM process

### Sausage-like micropillar structures

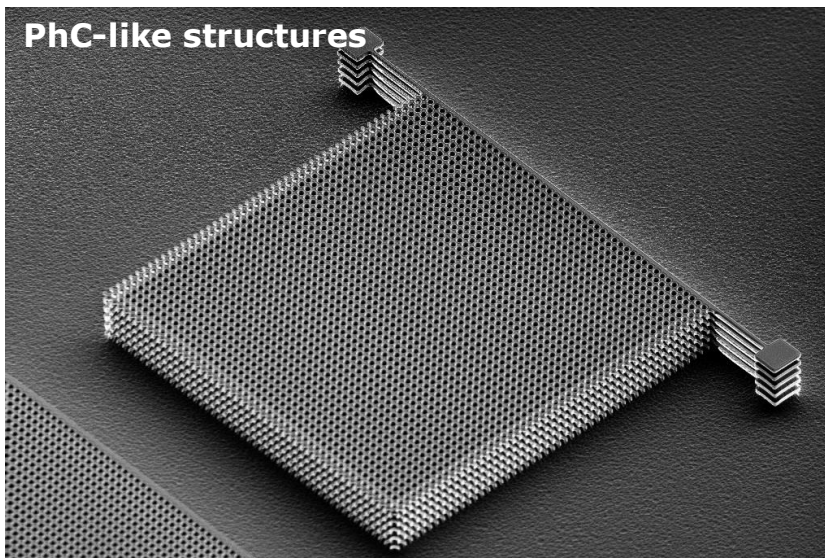


### Gear-like structures





## PhC-like structures

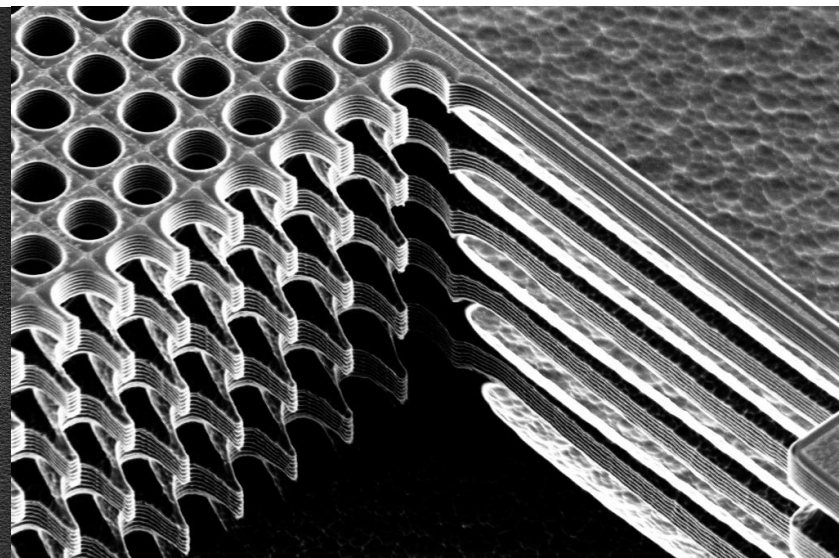


20  $\mu\text{m}$

EHT = 3.00 kV  
Signal A = SE2  
WD = 13.9 mm

Mag = 957 X  
Pixel Size = 281.7 nm

Contrast = 28.0 %  
Brightness = 43.6 %

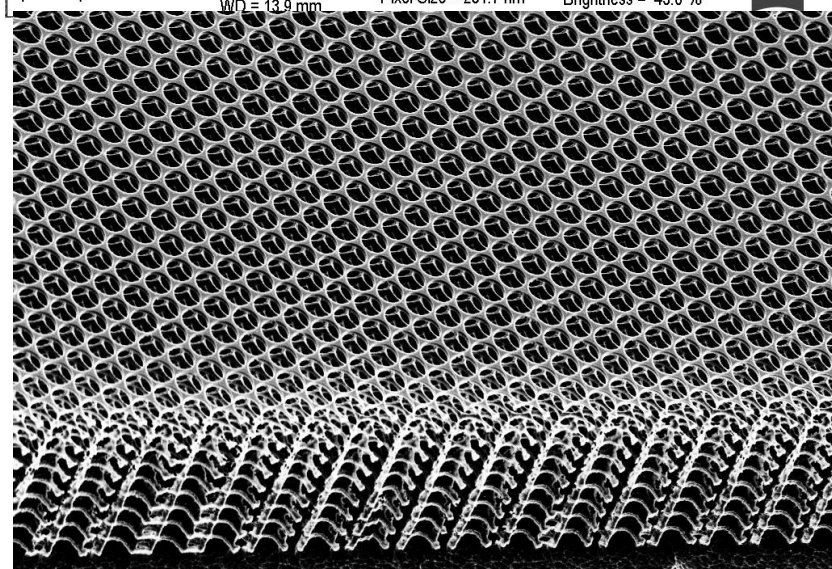


2  $\mu\text{m}$

EHT = 3.00 kV  
Signal A = SE2  
WD = 13.8 mm

Mag = 7.98 K X  
Pixel Size = 33.78 nm

Contrast = 28.1 %  
Brightness = 43.6 %

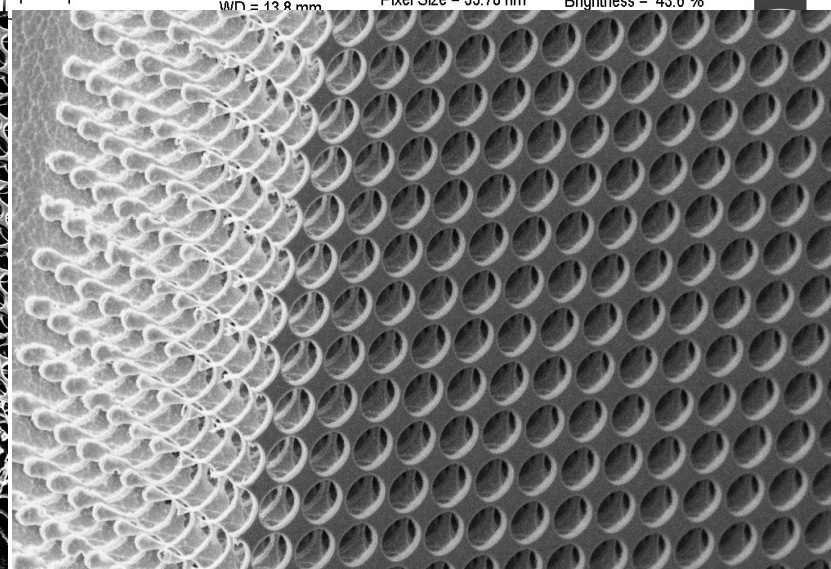


3  $\mu\text{m}$

EHT = 3.00 kV  
WD = 15.2 mm  
Mag = 5.72 K X

Signal A = SE2  
Pixel Size = 51.37 nm  
Vacuum Mode = High Vacuum

Tilt Angle = 0.0 °  
Brightness = 28.2 %  
Contrast = 33.1 %  
Date : 3 Nov 2017  
Time : 8:56:35



2  $\mu\text{m}$

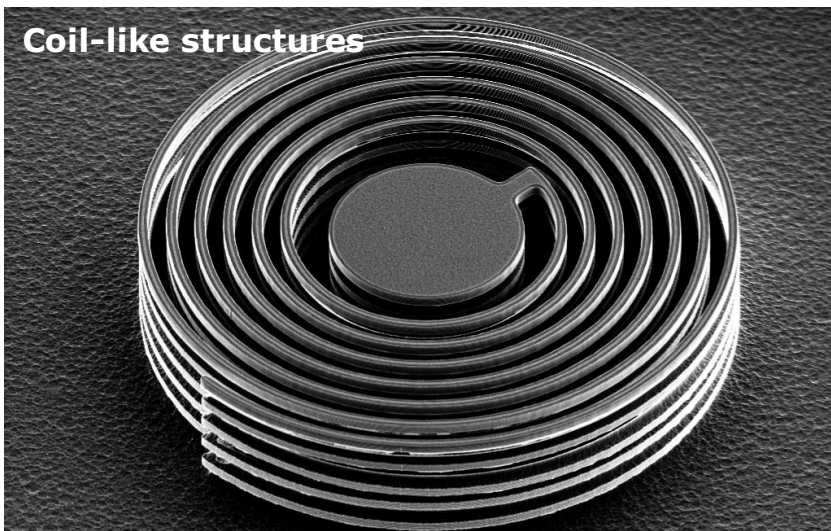
EHT = 3.00 kV  
WD = 15.1 mm  
Mag = 9.54 K X

Signal A = InLens  
Pixel Size = 30.81 nm  
Vacuum Mode = High Vacuum

Tilt Angle = 0.0 °  
Brightness = 47.4 %  
Contrast = 46.4 %  
Date : 3 Nov 2017  
Time : 8:52:33



## Coil-like structures

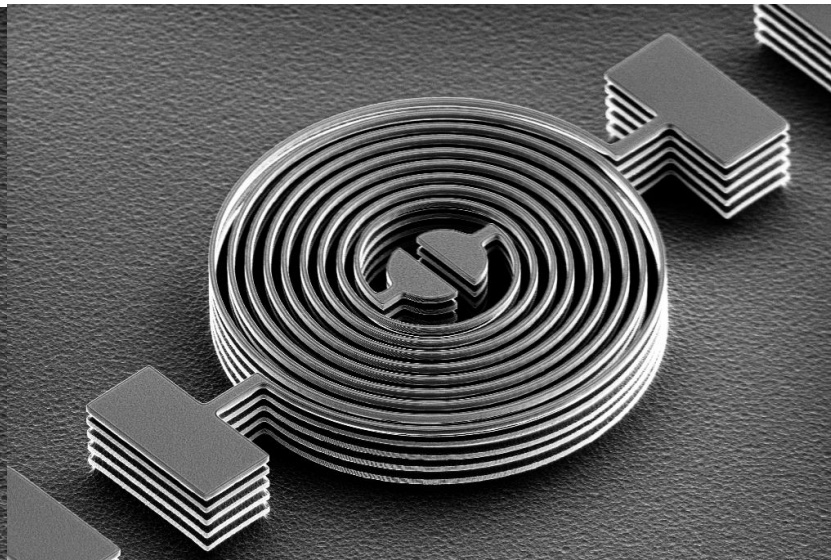


10  $\mu\text{m}$

EHT = 3.00 kV  
Signal A = SE2  
WD = 13.8 mm

Mag = 2.32 K X  
Pixel Size = 116.4 nm

Contrast = 27.8 %  
Brightness = 43.6 %



20  $\mu\text{m}$

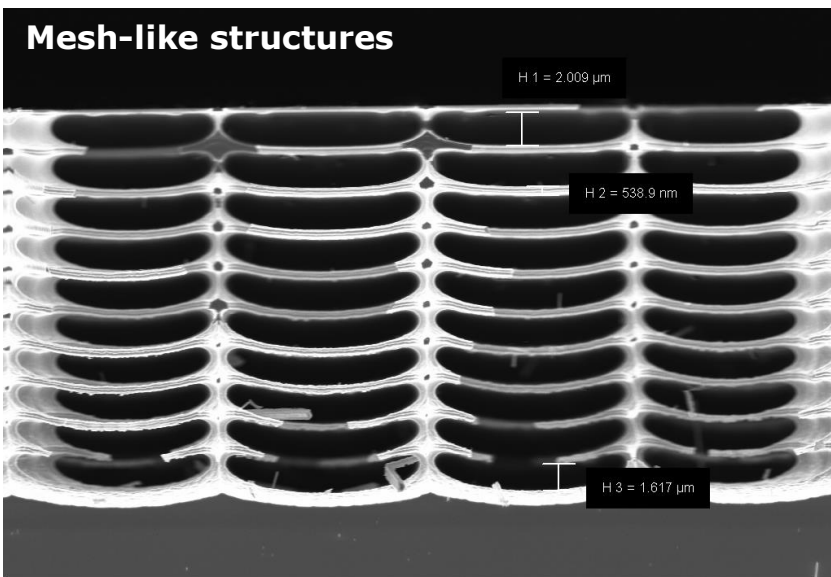
EHT = 3.00 kV  
Signal A = SE2  
WD = 13.8 mm

Mag = 1.48 K X  
Pixel Size = 182.1 nm

Contrast = 28.0 %  
Brightness = 43.6 %



## Mesh-like structures



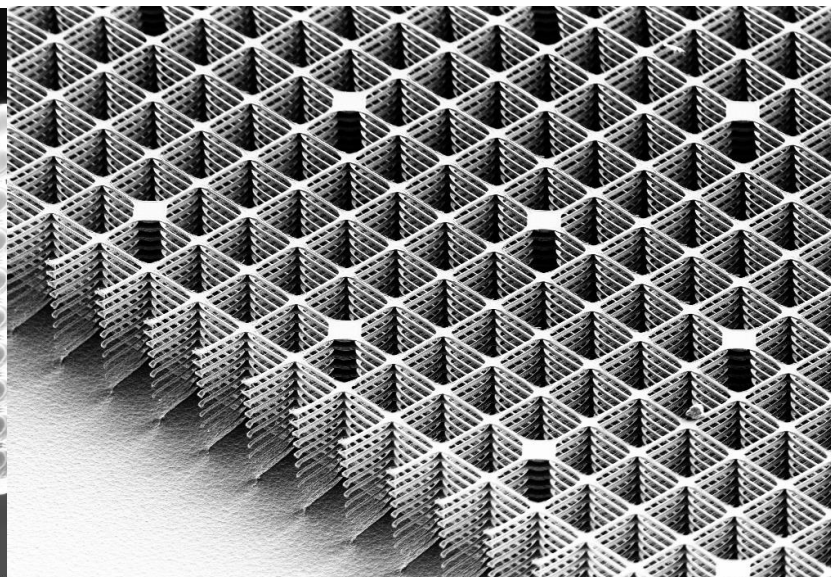
2  $\mu\text{m}$

EHT = 3.00 kV  
WD = 3.5 mm  
Mag = 6.00 K X

Signal A = InLens  
Pixel Size = 48.99 nm  
Vacuum Mode = High Vacuum

Tilt Angle = 0.0 °  
Brightness = 50.0 %  
Contrast = 25.8 %

Date : 7 Mar 2018  
Time : 18:23:13



20  $\mu\text{m}$

EHT = 3.00 kV  
WD = 15.7 mm  
Mag = 2.00 K X

Signal A = SE2  
Pixel Size = 147.0 nm  
Vacuum Mode = High Vacuum

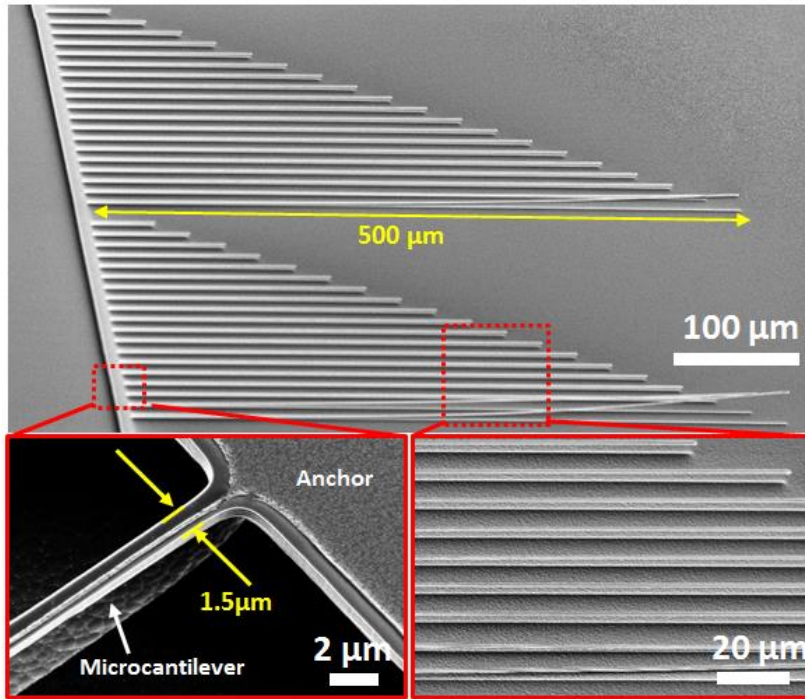
Tilt Angle = 0.0 °  
Brightness = 42.7 %  
Contrast = 28.2 %

Date : 9 Mar 2018  
Time : 8:50:58

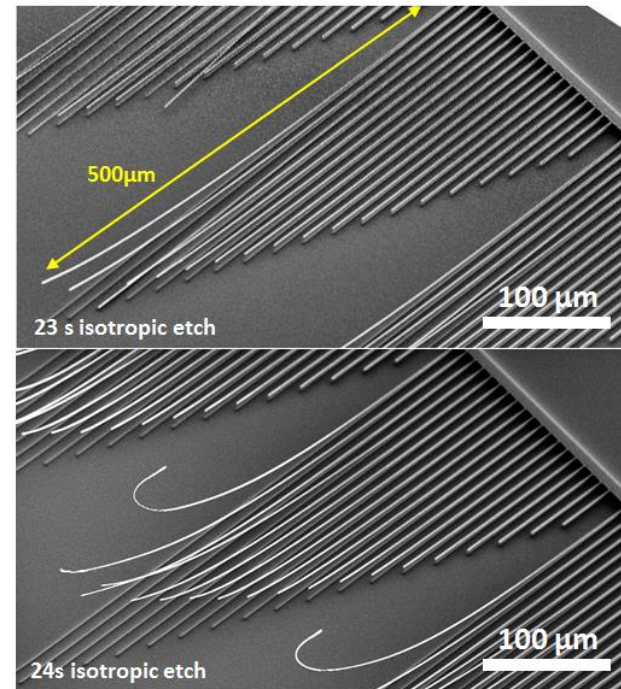


# Suspended silicon structures created with modified DREM process

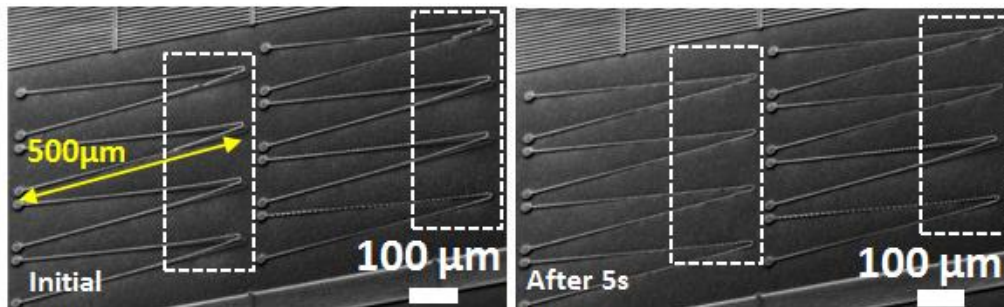
Ultralong cantilevers by dry releasing



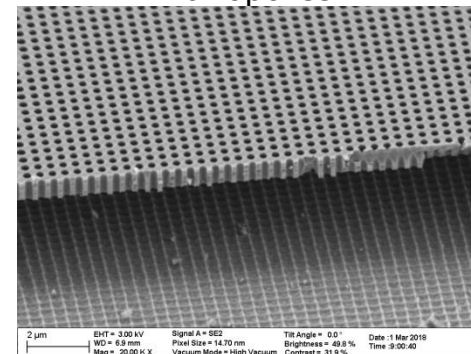
Folding of ultralong cantilevers



Clamping driven by electrostatic force

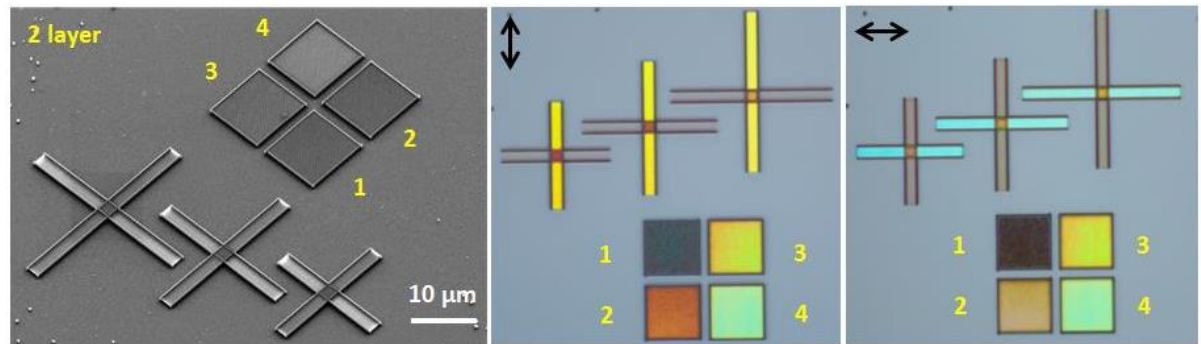
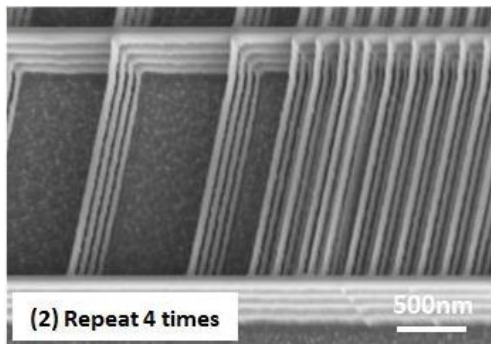
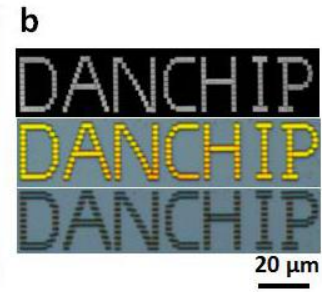
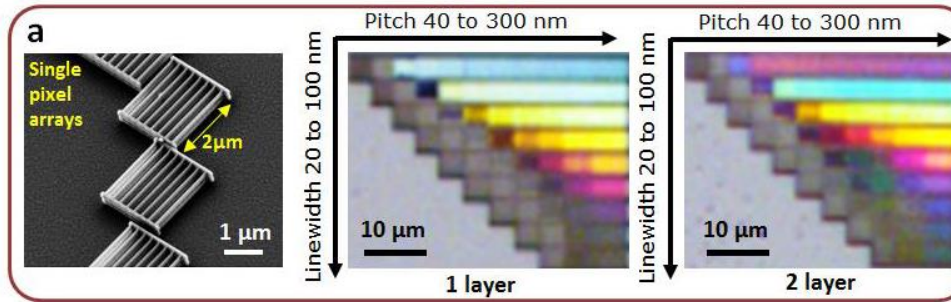
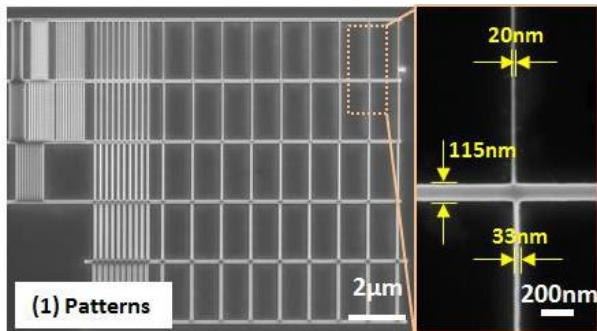
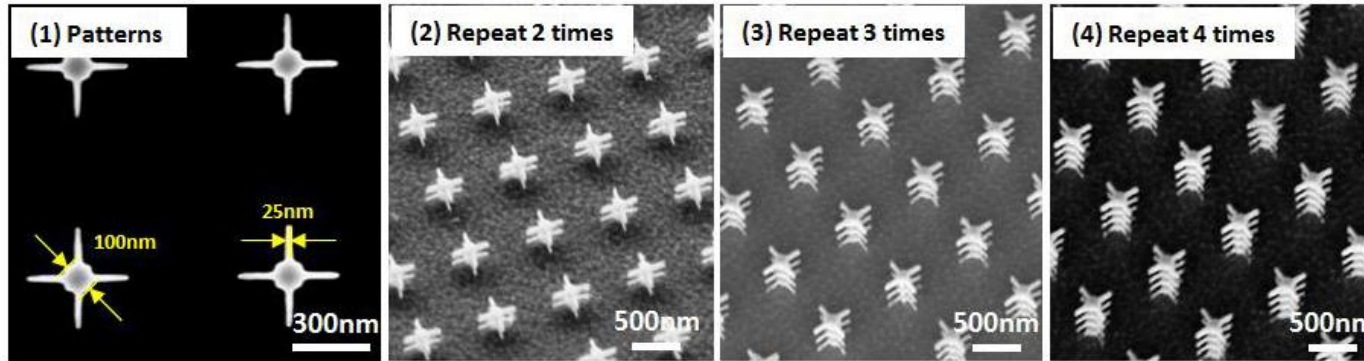


Suspended membranes with nanopores



## 3D nanostructures created with modified DREM process

- Patterned with e-beam lithography, polarization dependent structural color generation





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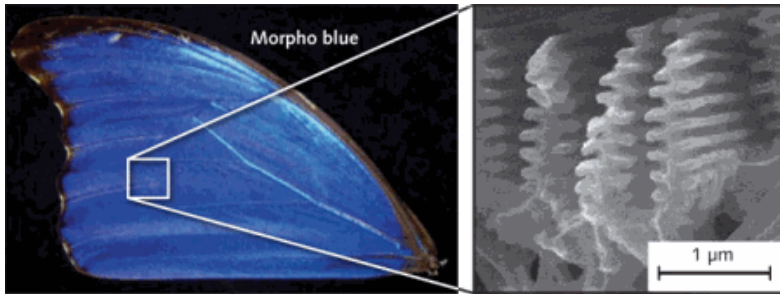
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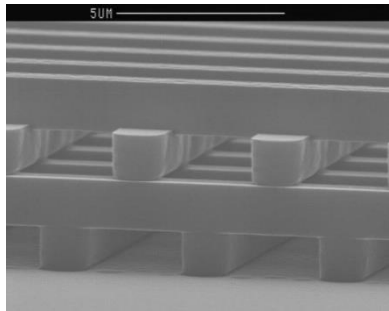
## 4. Conclusions and perspectives

# Large area 3D photonic crystal membranes with embedded planar cavities

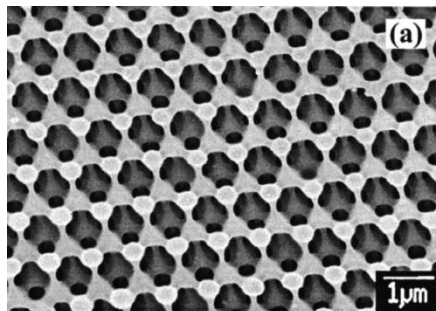


Saito, A., Osaka University

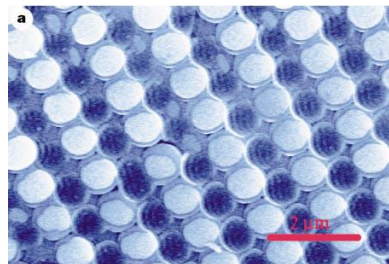
- Complicated process flow using traditional method (woodpile, inverse opal, etc);
- Time consuming fabrication process (2 photon polymerization, etc);
- Non-conventional fabrication method (multi-angle lithography or etching);
- Difficult for integration;



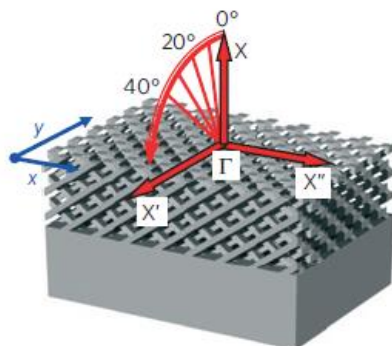
Lin, S.Y., et al. 1998.



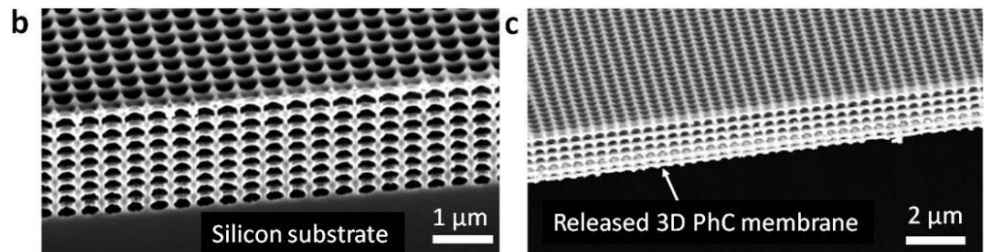
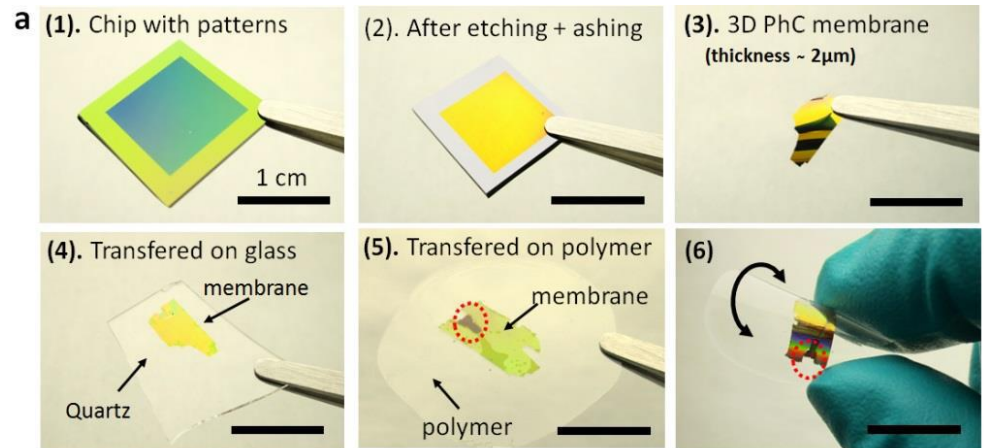
Wang. X., et al. 2000.



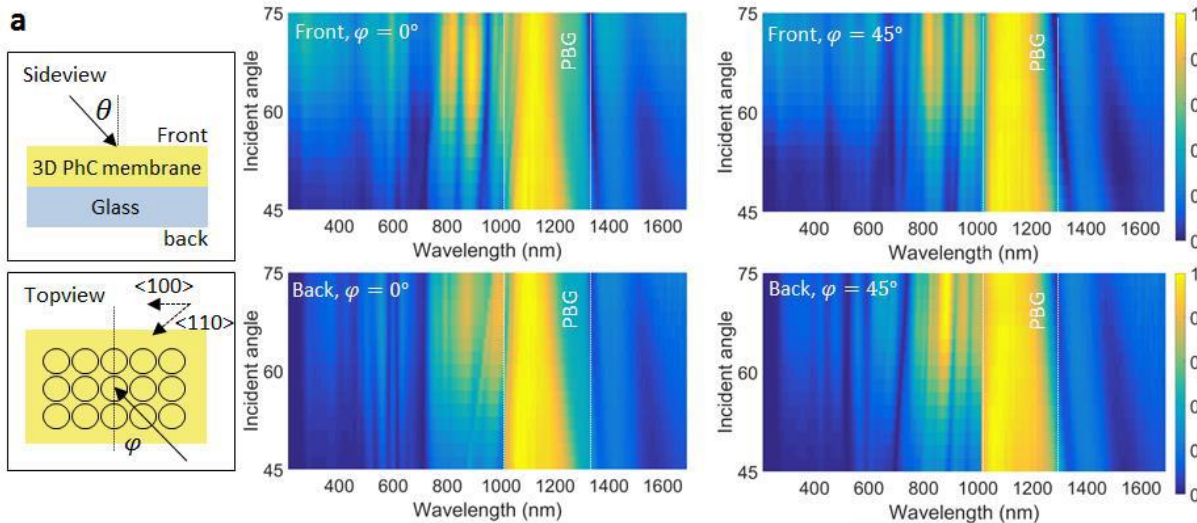
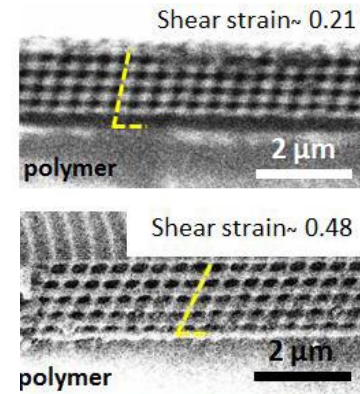
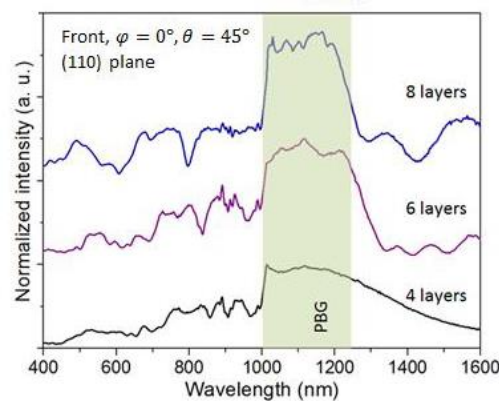
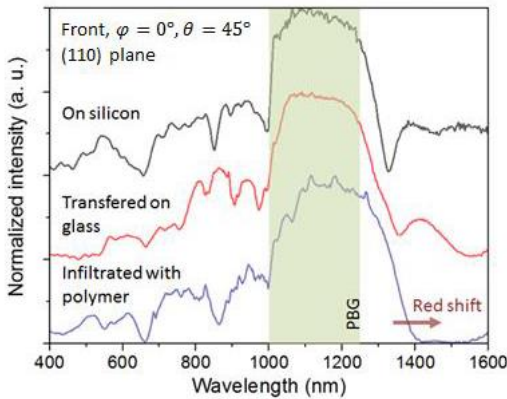
Blanco, A, et al. 2000.



Takahashi, S., et al. 2000.

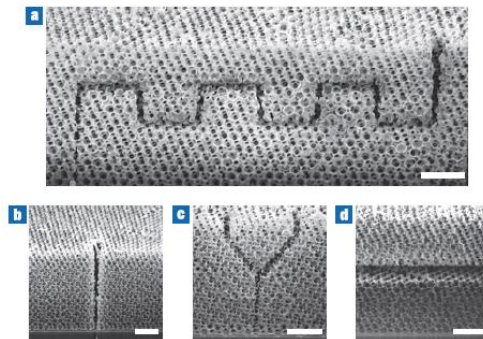


- Complete bandgap;
- Capability to be transferred onto other substrates;
- Feasibility for introducing planar cavities.

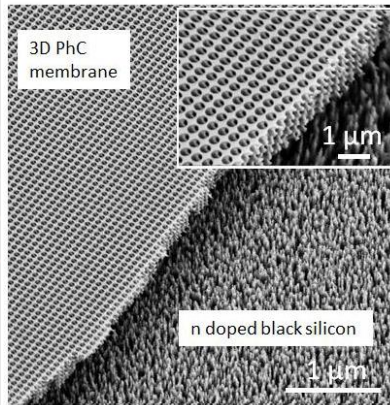
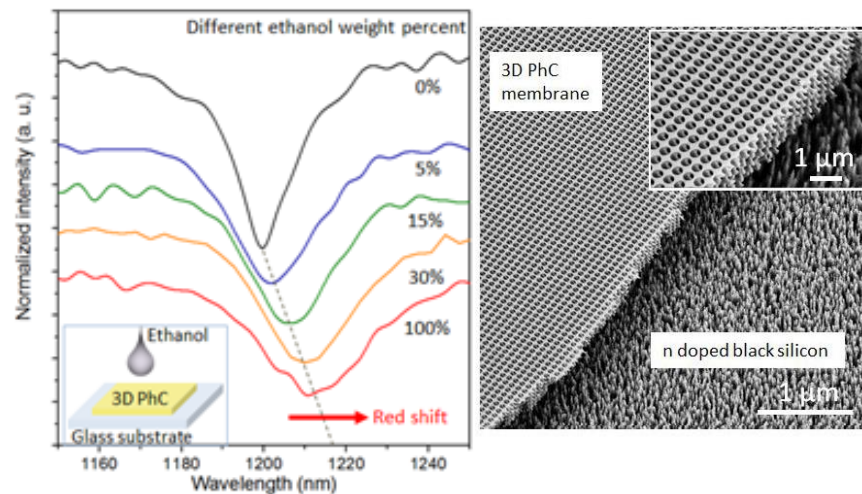
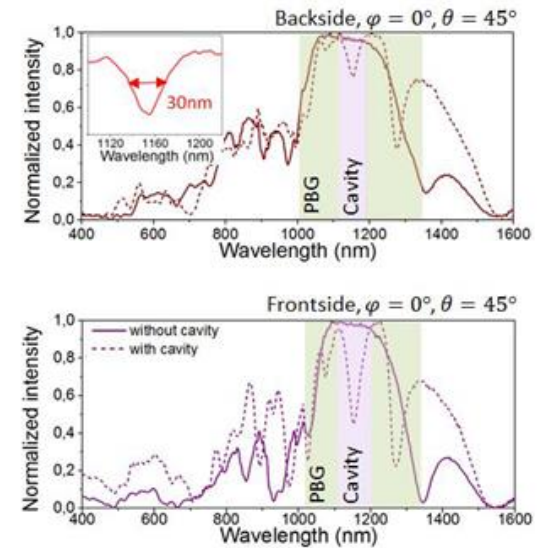
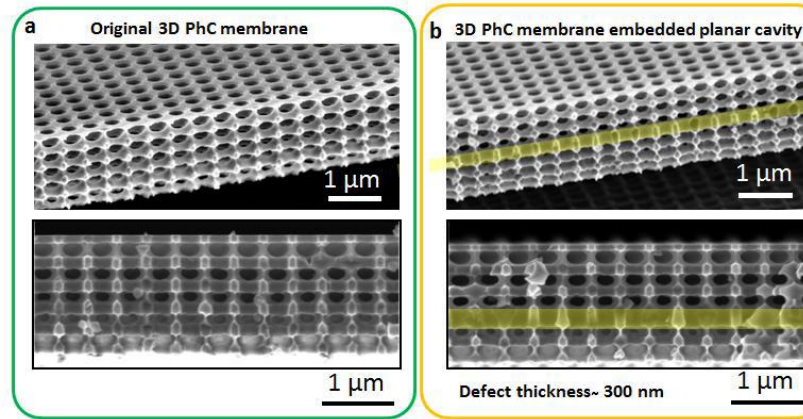




- Applications with embedded planar cavities



Rinne, S.A., et al. 2008.



## FULL PAPER

3D Photonic Crystals

# Large Area Three-Dimensional Photonic Crystal Membranes: Single-Run Fabrication and Applications with Embedded Planar Defects

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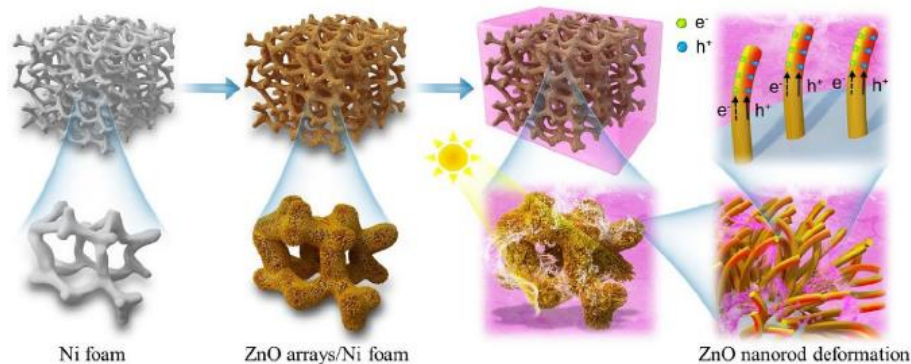
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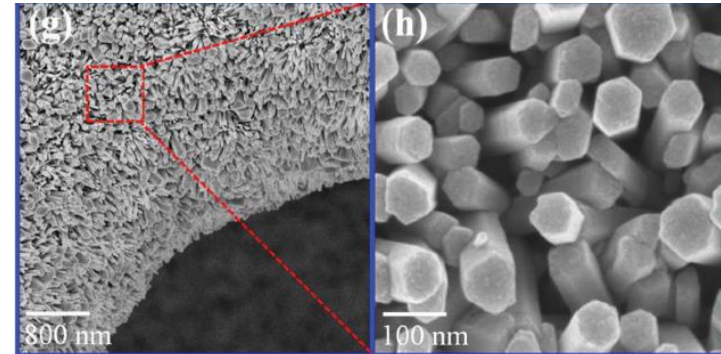


### 3. Applications of fabricated 3D silicon micro- and nanostructures

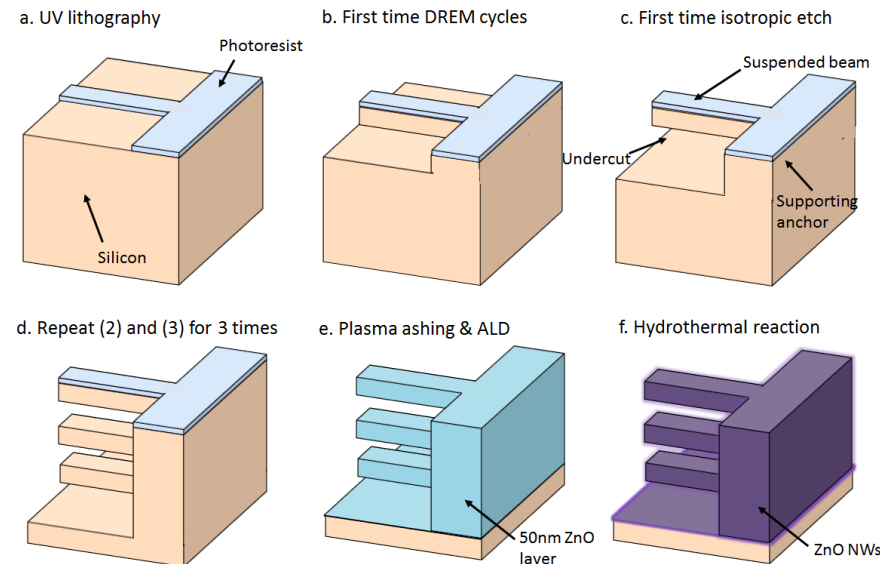
Integration of 3D silicon micro-mesh structures with ZnO nanowires for photodegradation and photocurrent generation



*Chen, X., et al. 2017.*

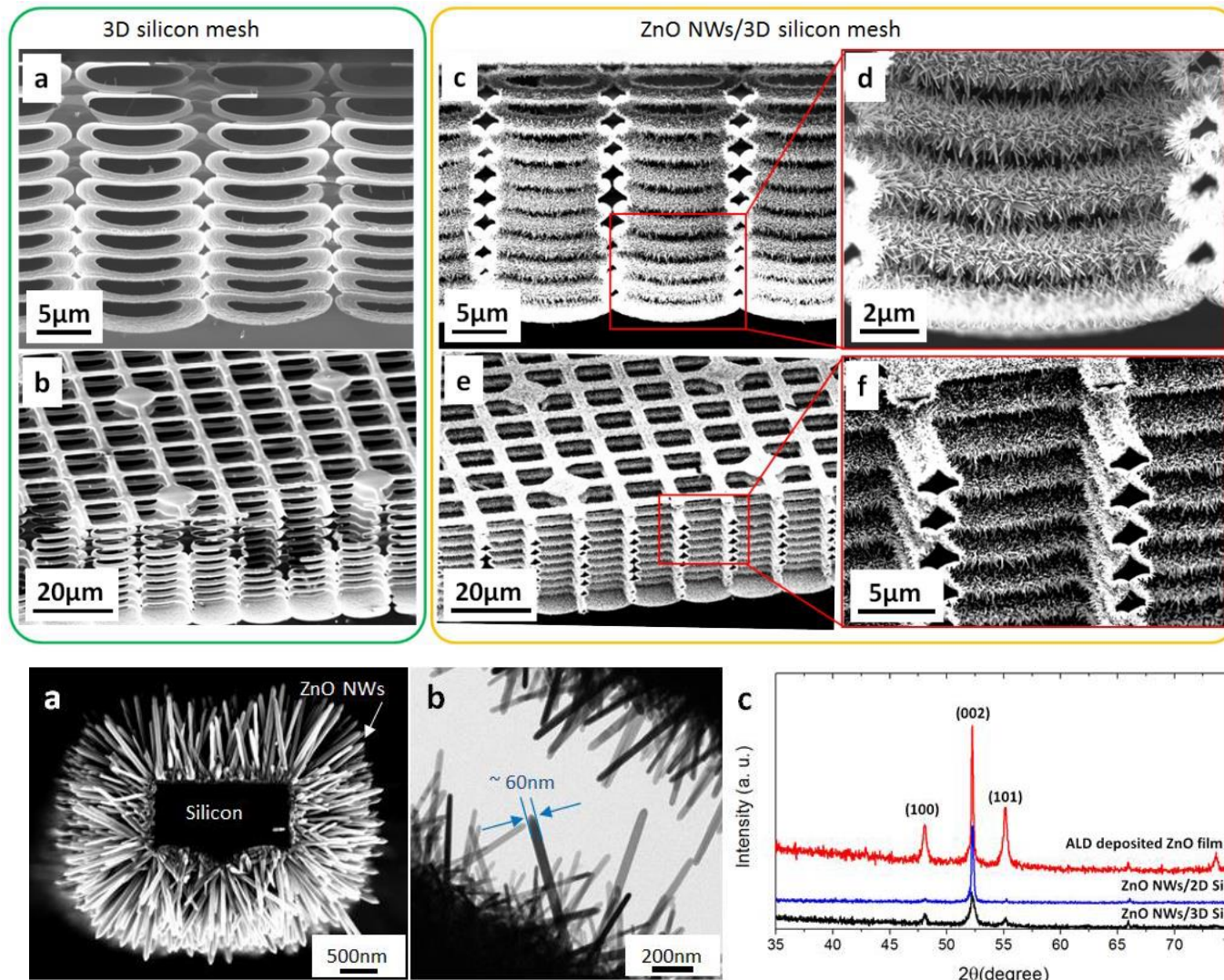


*Shao, D., et al. 2015.*



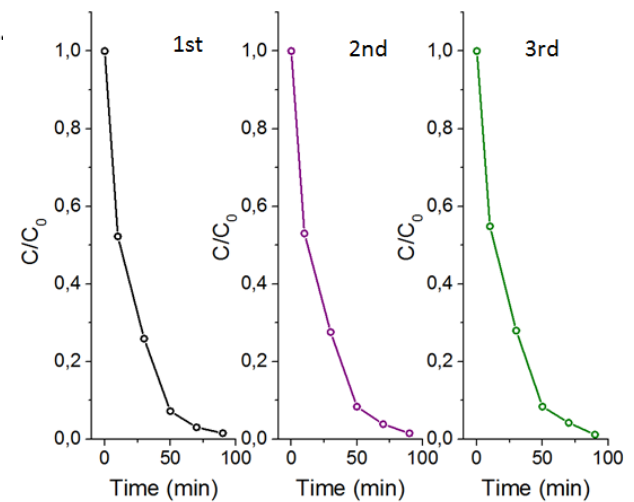
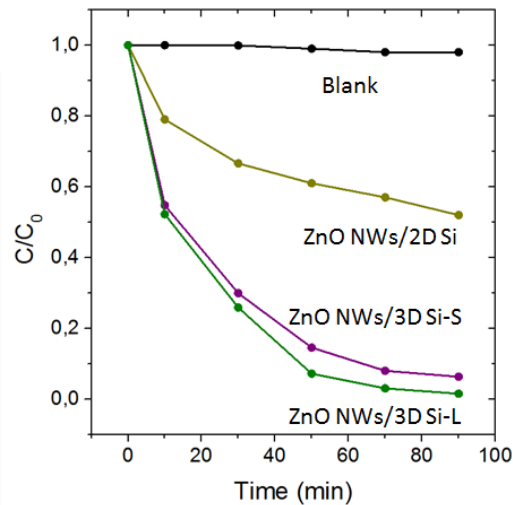
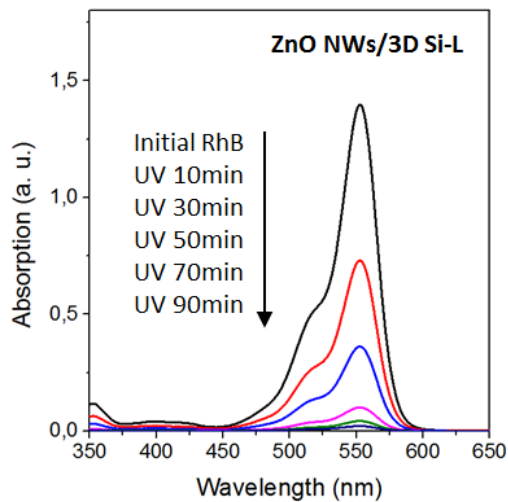
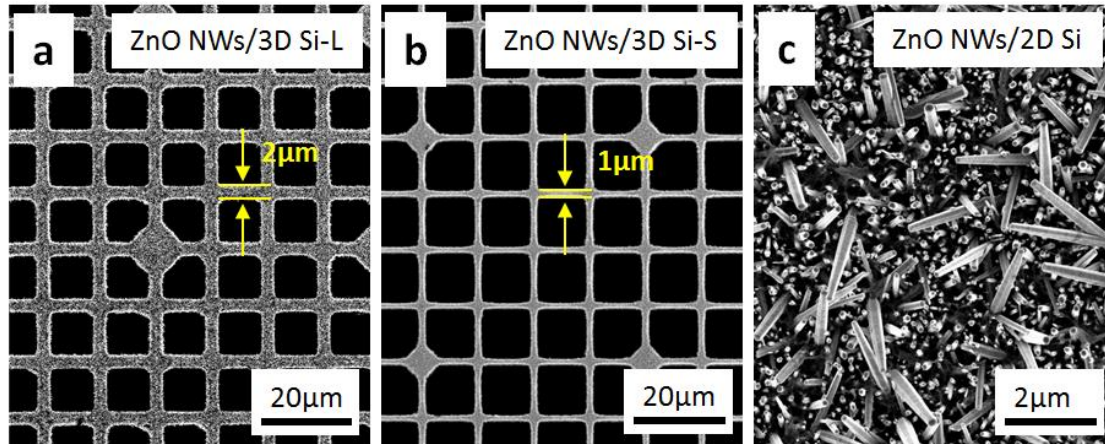
*Ko, S. H., et al. 2011.*

- ZnO nanowires density increased by around 1 magnitude.

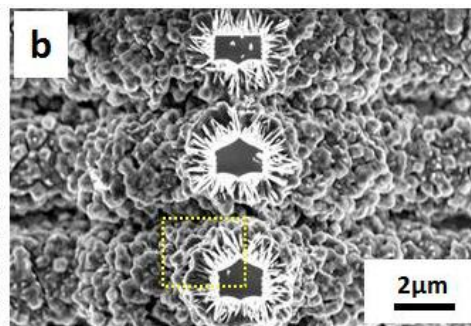
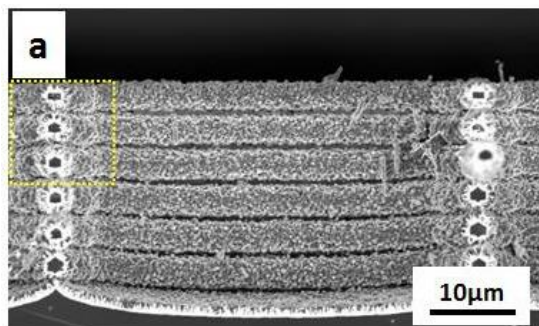
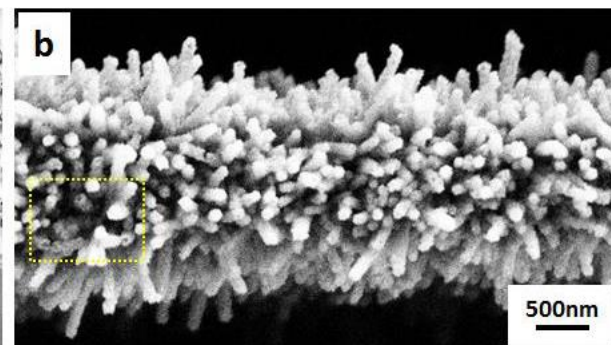
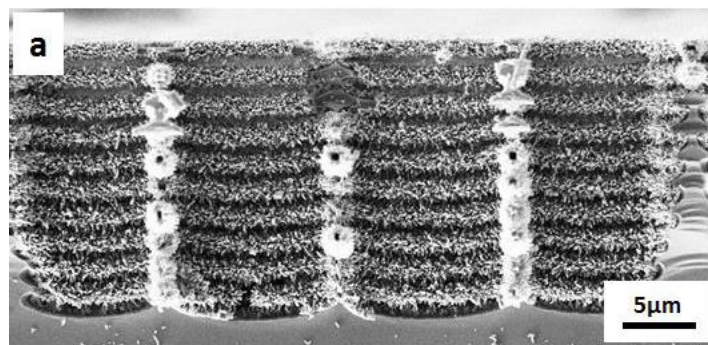
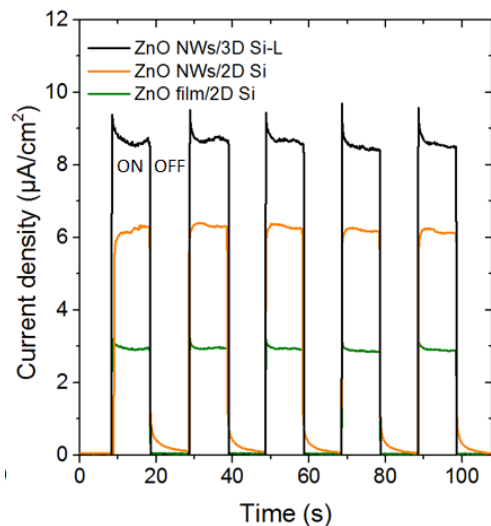




- Improved photodegradation rate of RhB dyes under UV light irradiation



- Improved photocurrent generation;
- conversion of ZnO for other materials (ZnS, ZIF-8).



ACES Asian Chemical Editorial Society

DOI: 10.1002/cnma.201800371

CHEMNANOMAT Full Paper

Photocatalysis

**Highly Ordered 3D Silicon Micro-Mesh Structures Integrated with Nanowire Arrays: A Multifunctional Platform for Photodegradation, Photocurrent Generation, and Materials Conversion**

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## 1. Introduction of the etching tool

- Etching machine: DRIE-Pegasus (SPTS);
- Real time monitoring system: OEI/OES, Claritas EPD, Oscilloscope, etc.

## 2. Introduction of the etching strategy

- DREM process;
- 3D DREM process.

## 3. Applications of fabricated 3D silicon micro- and nanostructures

- 3D photonic crystal membranes;
- ZnO nanowires/3D silicon micromesh for photocurrent and photocatalysis

## 4. Conclusions and perspectives

## 4. Conclusions and perspective

- Transferring 3D silicon structures into other materials;
- Postprocess of 3D structures (e.g. annealing, laser reshaping, etc).

